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Cross-Process Interference in Strong-Field Ionization: Insights from CEP-Dependent Photoelectron Spectra

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Photoelectron spectra from strong-field ionization show features like energy cutoffs and interference patterns, influenced by direct and backscattered electrons [1]. The typical cut-offs at $2U$ and $10U$ can be explained within the famous three-step model, while quantum inter- and intracycle interferences are typically associated with selfinterference of direct or backscattered, respectively [2,3]. However, also cross-process interference (CPI) between direct and backscattered electrons could reveal further insights. To isolate CPI, competing effects from self-interference must be suppressed, achievable with singlecycle laser pulses [4] that confine electron emission to a single optical period. Metallic nanotips further enhance this by restricting electron motion to one half-space, ensuring strong backscattering [5]. Quantum simulations predict CEP-dependent photoelectron spectra with distinct interference patterns. An extended trajectory model confirms these features originate from CPI, offering insights into the underlying physical mechanisms.

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[3] D.G. Arbó et al., Physical Review A 74, 063407 (2006)

[4] M.T. Hassan et al., Nature 530, 66-70 (2016)

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